# Notice of References Cited Application/Control No. 10/519,852 Examiner Alissa L. Hoey Applicant(s)/Patent Under Reexamination TAKEDA ET AL. Page 1 of 2

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-D444,940	07-2001	Murrey, Regina L.	D2/989
*	В	US-366,503	07-1887	ONiell	36/140
*	С	US-1,308,483	07-1919	Craighead	2/239
*	D	US-1,741,340	12-1929	SCHOLL WILLIAM M	2/239
*	Е	US-1,798,201	03-1931	HEDGES SAMUEL H	2/239
*	F	US-2,422,736	06-1947	LAMBERT CLARE A	2/241
*	G	US-3,013,564	12-1961	HAROLD LEVEY	36/170
*	Η	US-3,128,763	04-1964	LANGENFELD ANDREW G; et. al.	128/894
*	ı	US-4,651,354	03-1987	Petrey, John O.	2/239
*	J	US-5,560,226	10-1996	Throneburg, James L.	66/185
*	К	US-5,774,898	07-1998	Malpee, Mitchell G.	2/239
*	ا ا	US-5,791,163	08-1998	Throneburg, James L.	66/178R
*	М	US-5,906,007	05-1999	Roberts, Liana Callas	2/239

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	EP 1518470 A1	03-2005	European Patent	TAKEDA et al.	A41B 11/00
	0		-			
	Р					
	Q		•			·
	R				•	
	s					
	T					

# **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/519,852 Examiner Alissa L. Hoey Applicant(s)/Patent Under Reexamination TAKEDA ET AL. Page 2 of 2

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,000,247	12-1999	Takeda et al.	66/187
*	В	US-6,016,575	01-2000	Prychak, Tim E.	2/239
*	С	US-6,021,527	02-2000	Lessard, John J.	2/239
*	D	US-6,138,281	10-2000	Chiaruttini, Claudio	2/239
*	Е	US-6,704,941	03-2004	Palm, Donna M.	2/239
*	F	US-6,708,348	03-2004	Romay, Joaquin	2/239
*	G	US-6,935,141	08-2005	Takeda et al.	66/187
*	Н	US-2004/0221371	11-2004	Kato, Susumu	002/239
*	-	US-2005/0235702	10-2005	Takeda et al.	066/186
	J	US-			,
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	· Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

# **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	×	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.